

Notice of References Cited	Application/Control No. 10/033,518	Applicant(s)/Patent Under Reexamination HOPE, ROBERT B.	
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U.S. PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Recycling Tires, 2001, internet, first paragraph.
	V	Plastics Consultancy Network, 2/1994, page 2.
	W	Rubber Grades, internet, page 1.
	X	ASTM International, see entire document.

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	U	IRRDB.NET, internet, see entire document.
	V	Britannica Student Encyclopedia, page 5.
	W	Classification of Exports, U.S. Census Bureau, pages 1 and 2.
	X	

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